

# Table of Contents

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### Research Articles

- 1      **Generation of Patterns From Concentric Ring Arrays With Dipoles and Waveguides**  
Ketavath Kumar Naik, KLEF, KL University, India
  
- 20     **Measurement and Monitoring System With Real Time Data Logging Based on Microcontroller**  
Abdelkrim Mohrem, Research Laboratory on the Electrification of Industrial Enterprises, University M'Hamed Bougara, Boumerdes Algeria  
Boukhemis Chetate, Research Laboratory on the Electrification of Industrial Enterprises, University M'Hamed Bougara, Boumerdes Algeria  
Houssem Eddine Guia, Research Laboratory on the Electrification of Industrial Enterprises, University M'Hamed Bougara, Boumerdes Algeria
  
- 41     **Single Stage C-Band Erbium-Doped Fiber Amplifier (EDFA) Development and Performance Evaluation**  
Sami D. Alaruri, Independent Scholar, USA
  
- 50     **Design of S-Band Antenna With L-Shaped Slits on Rectangular Patch With Defected Ground Structure**  
Ketavath Kumar Naik, KLEF, KL University, Guntur, India  
Ravi Kumar Palla, GMRIT, Rajam, India  
Sriram Sandhya Rani, Jayamukhi Institute of Technological Sciences, India  
Dattatreya Gopi, KL University, Guntur, India

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